

230646 - MND - Micro and Nano Electronic Design

Coordinating unit:	230 - ETSETB - Barcelona School of Telecommunications Engineering
Teaching unit:	710 - EEL - Department of Electronic Engineering
Academic year:	2017
Degree:	MASTER'S DEGREE IN ELECTRONIC ENGINEERING (Syllabus 2013). (Teaching unit Compulsory) MASTER'S DEGREE IN ELECTRONIC ENGINEERING (Syllabus 2009). (Teaching unit Optional) MASTER'S DEGREE IN INFORMATION AND COMMUNICATION TECHNOLOGIES (Syllabus 2009). (Teaching unit Optional) DEGREE IN TELECOMMUNICATIONS ENGINEERING (Syllabus 1992). (Teaching unit Optional)
ECTS credits:	5
Teaching languages:	English

Teaching staff

Coordinator:	JORDI MADRENAS BOADAS
Others:	FRANCESC MOLL ECHETO, JORDI COSP VILELLA Madrenas Boadas, Jordi

Degree competences to which the subject contributes

Specific:

1. Ability to design CMOS digital and analog integrated circuits of medium complexity.
2. Ability to apply low-power techniques to integrated circuits (ICs).
3. Ability to design for testability and test schemes for ICs.

Transversal:

4. EFFECTIVE USE OF INFORMATION RESOURCES: Managing the acquisition, structuring, analysis and display of data and information in the chosen area of specialisation and critically assessing the results obtained.
5. FOREIGN LANGUAGE: Achieving a level of spoken and written proficiency in a foreign language, preferably English, that meets the needs of the profession and the labour market.

Teaching methodology

- Lectures
- Laboratory classes
- Laboratory practical work
- Group work (distance)
- Oral presentations
- Short answer test (Control)
- Extended answer test (Final Exam)

Learning objectives of the subject

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The aim of this course is to train students in methods of integrated circuit design. First, state-of-the-art and trends in VLSI and their design implications are introduced. Then, basic analog and digital circuits are presented. In a second phase, low-power techniques and design for testability are developed. Lab projects are proposed to introduce the practical aspects of VLSI design and the CAE tools.

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Learning results of the subject:

- Ability to understand the evolution of integrated technologies.
- Ability to identify cases and applications suitable for an integrated solution.
- Ability to analyze the characteristics of a mixed-signal integrated circuit.
- Ability to design analog and digital medium-complexity CMOS integrated circuits.

Study load

Total learning time: 125h	Hours large group:	26h	20.80%
	Hours medium group:	0h	0.00%
	Hours small group:	13h	10.40%
	Guided activities:	0h	0.00%
	Self study:	86h	68.80%

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Content

<p>1. Introduction</p>	<p>Learning time: 8h Theory classes: 3h Self study : 5h</p>
<p>Description:</p> <ul style="list-style-type: none"> - Structure of static gates. - Manufacturing process. Masks. Layout. - MOSFET models. - State-of-the-art in VLSI. Full-custom and standard-cell design. 	
<p>2. Basic digital blocks and their characterization</p>	<p>Learning time: 20h Theory classes: 7h Laboratory classes: 2h Self study : 11h</p>
<p>Description:</p> <ul style="list-style-type: none"> - The CMOS inverter. The NAND and NOR gates. Pass transistors. Tri-state. Latches. Flip-flops. Memory cells. Layout. - Parasitic elements. Delay definitions. Logical effort. - Power dissipation. 	
<p>3. Basic analog blocks and their characterization</p>	<p>Learning time: 20h Theory classes: 7h Laboratory classes: 2h Self study : 11h</p>
<p>Description:</p> <ul style="list-style-type: none"> - Current sources and mirrors. - Basic amplifier stages. - Voltage and current references. - Matching. Transistor sizing. Layout. - Small-signal model. Parasitics and frequency response. 	

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<p>4. Practical aspects of VLSI design</p>	<p>Learning time: 16h Theory classes: 5h Laboratory classes: 2h Self study : 9h</p>
<p>Description:</p> <ul style="list-style-type: none"> - Buffering. - Power and clock distribution. - Input/output pads. Packaging. - Low-power circuit- and architecture-level techniques. 	
<p>5. Basic concepts of testing</p>	<p>Learning time: 12h Theory classes: 4h Laboratory classes: 2h Self study : 6h</p>
<p>Description:</p> <ul style="list-style-type: none"> - Definitions. Manufacturing test. Defects and faults. - Design for testability. Test coverage. ATPG. - Self-test. Fault tolerance. System-level test. - Design for manufacturability. 	
<p>6. Laboratory of VLSI design</p>	<p>Learning time: 49h Laboratory classes: 5h Self study : 44h</p>
<p>Description:</p> <ul style="list-style-type: none"> - Introduction to CAE tools for VLSI. Layout editor. Electric and logic simulation. Synthesis. Placement & routing. Post-layout simulation. - Design of a transconductor. - Design of a simple digital processor. - Design project: digitally-assisted analog front-end. 	

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Planning of activities

LABORATORY

Description:

- Introduction to CAE tools for VLSI. Design rules, layout, electric and logic simulation, synthesis, placement & routing, backannotation.
- Design of a transistor.
- Design of a simple digital processor.
- Design project. Front-end and back-end.

ORAL PRESENTATION

Description:

Presentation of a work group.

SHORT ANSWER TEST (CONTROL)

Description:

Mid term control.

EXTENDED ANSWER TEST (FINAL EXAMINATION)

Description:

Final examination.

Qualification system

Final examination: 35%

Midterm examination: 35%

Laboratory assessments: 30%

Bibliography

Basic:

Weste, N.H.E.; Harris, D.M. CMOS VLSI design: a circuits and systems perspective. 4th ed. Boston: Addison Wesley, 2011. ISBN 9780321547743.

Complementary:

Lin, Ming-Bo. Introduction to VLSI systems: a logic, circuit, and system perspective. Boca Ratón: CRC Press, 2012. ISBN 9781439868591.

Baker, R.J. CMOS circuit design, layout, and simulation. 3rd ed. Hoboken, NJ: IEEE Press : Wiley, 2010. ISBN 9780470881323.